

<b>Notice of References Cited</b>	Application/Control No. 09/842,025	Applicant(s)/Patent Under Reexamination BU ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0097331	05-2003	Cohen, Morris E.	705/39
*	B	US-2002/0133491	09-2002	Sim et al.	707/10
*	C	US-2001/0042010	11-2001	Hassell, David A.	705/14
*	D	US-6,895,584	05-2005	Belkin, Ruslan	718/100
*	E	US-6,854,009	02-2005	Hughes, Trevor	709/220
*	F	US-6,278,532	08-2001	Heimendinger et al.	358/442
*	G	US-6,170,017	01-2001	Dias et al.	709/235
*	H	US-5,983,273	11-1999	White et al.	709/229
*	I	US-5,758,126	05-1998	Daniels et al.	715/780
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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